

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/630,999	<b>Applicant(s)/Patent under Reexamination</b> BODIN ET AL.
<b>Examiner</b> Syed Zaidi	<b>Art Unit</b> 2616	

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (please see search history)	12/5/2007	SZ
Inventor : Bodin et al.	12/05/07	SZ
Consulted with SPE Seema Rao	12/05/07	SZ
(370/229 370/221 370/222 370/224 370/225 370/226 370/228).CCLS.	12/05/07	SZ
(IEEE Xplore Database( <a href="http://ieeexplore.ieee.org/Xplore/DynWel.jsp">http://ieeexplore.ieee.org/Xplore/DynWel.jsp</a> )	12/5/2007	SZ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner